


<b>Search Notes</b>  	<b>Application/Control No.</b>  10759346	<b>Applicant(s)/Patent Under Reexamination</b>  SZPAK ET AL.
	<b>Examiner</b>  SIMON KE	<b>Art Unit</b>  2174

SEARCHED			
Class	Subclass	Date	Examiner
715	764, 964,735,	2/3/08	PK
716	4	2/3/08	PK
345	173	2/3/08	PK
715	764, 964,735,	6/5/08	PK
715	764,964,735	3/28/09	PK

SEARCH NOTES		
Search Notes	Date	Examiner
East Text Search (US-PGPUB; USPAT; Derwent)	2/3/08	PK
East Text Search (US-PGPUB; USPAT; Derwent)	6/5/08	PK
East Text Search (US-PGPUB; USPAT; Derwent)	3/28/09	PK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/SIMON KE/ Primary Examiner.Art Unit 2174
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